
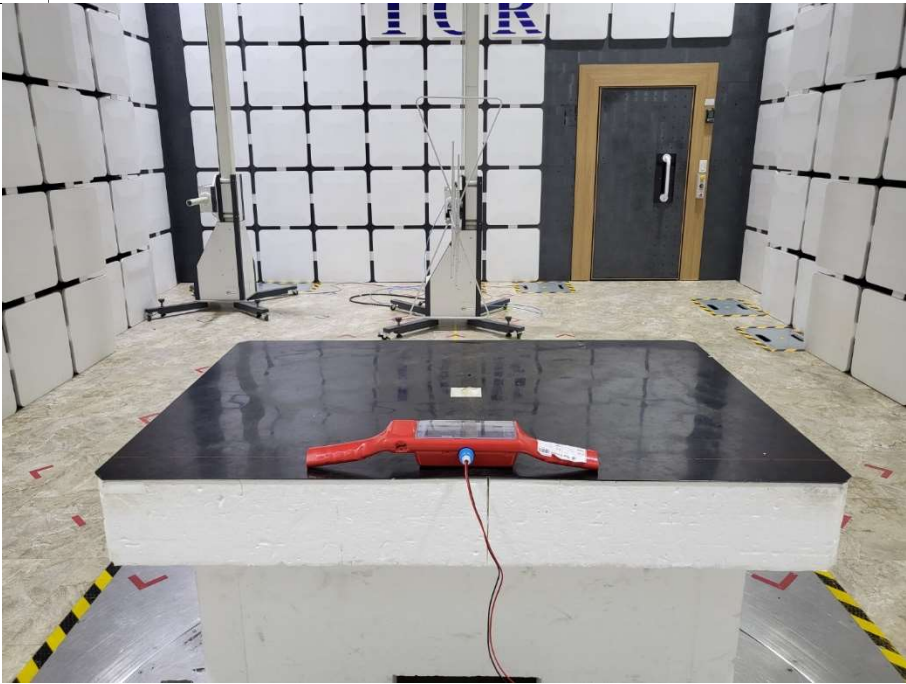




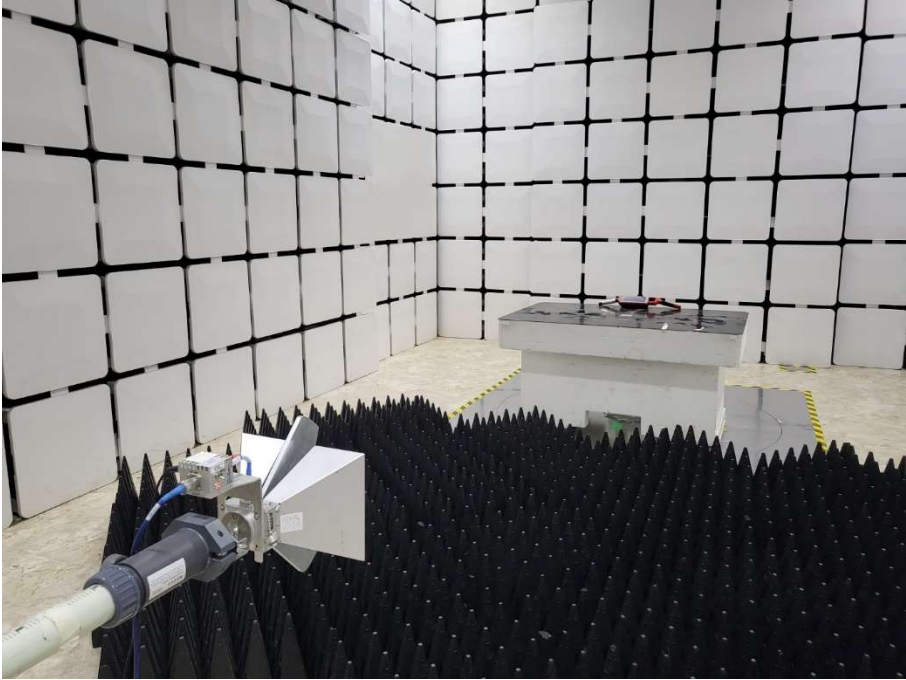
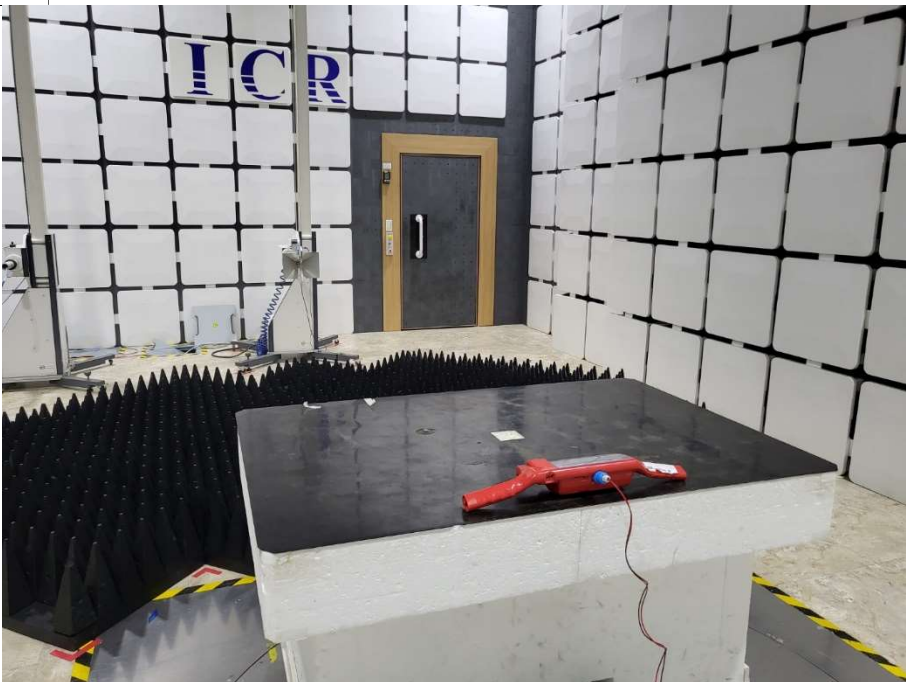
Test Setup Photo

Test Setup	Radiated measurement for below 1 GHz (Front side) – Charging mode
	
Test Setup	Radiated measurement for below 1 GHz (Rear side) – Charging mode
	

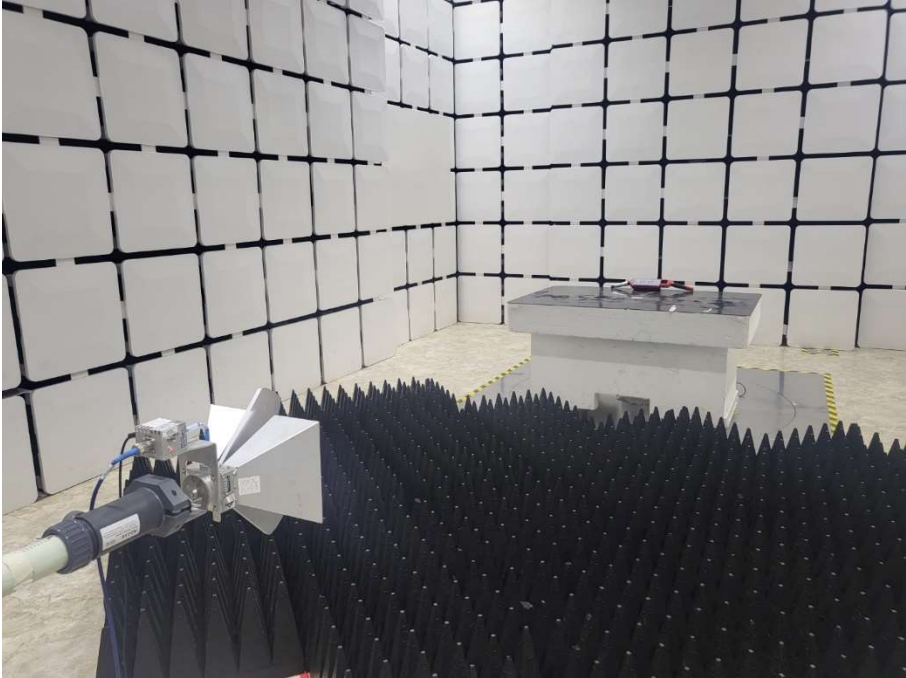
Test Setup Photo

Test Setup	Radiated measurement for below 1 GHz (Front side) – Operating mode
	
Test Setup	Radiated measurement for below 1 GHz (Rear side) – Operating mode
	

Test Setup Photo

Test Setup	Radiated measurement for above 1 GHz (Front side) – Charging mode
	 A photograph showing the front side of the test setup inside an anechoic chamber. The walls are covered with white square absorbers. The floor is covered with a dense layer of black pyramidal absorbers. A white table is positioned in the center, and a red device is placed on it. A probe is visible in the foreground, pointing towards the table.
Test Setup	Radiated measurement for above 1 GHz (Rear side) – Charging mode
	 A photograph showing the rear side of the test setup inside an anechoic chamber. The walls are covered with white square absorbers. The floor is covered with a dense layer of black pyramidal absorbers. A white table is positioned in the center, and a red device is placed on it. A door is visible in the background, and the letters 'ICR' are visible on the wall.

Test Setup Photo

Test Setup	Radiated measurement for above 1 GHz (Front side) – Operating mode
	
Test Setup	Radiated measurement for above 1 GHz (Rear side) – Operating mode
	